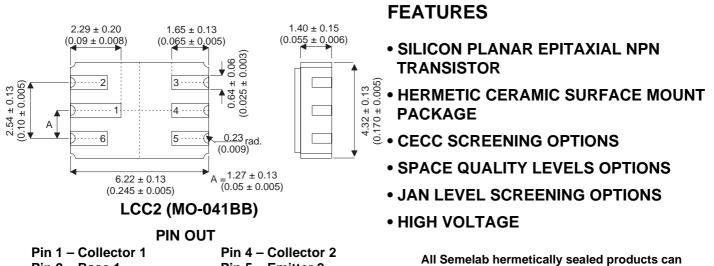
2N3501DCSM



MECHANICAL DATA

Dimensions in mm (inches)

DUAL BIPOLAR NPN DEVICES IN A HERMETICALLY SEALED LCC2 CERAMIC SURFACE MOUNT PACKAGE FOR HIGH RELIABILITY APPLICATIONS



Pin 2 – Base 1 Pin 3 – Base 2 Pin 4 – Conector 2 Pin 5 – Emitter 2 Pin 6 – Emitter 1

All Semelab hermetically sealed products car be processed in accordance with the requirements of BS, CECC and JAN, JANTX, JANTXV and JANS specifications.

ABSOLUTE MAXIMUM RATINGS

	(T _{case} = 25°C unless otherwise stated)		Single Side	Total Device	
V _{CBO}	Collector-Base Voltage		150V		
V _{CEO}	Collector-Emitter Voltage(I _B =0)		150V		
V_{EBO}	Emitter-Base Voltage(I _B =0)		6V		
I _C	Continuous Collector Current		300mA		
PD	Power Dissipation	Tamb = 25°C	300mW	500mW	
		Derate above 25°C	1.72mW/°C	2.86mW/°C	
Т _ј	Operating Temperature Range		-65 to 200°C		
T _{stg}	Storage Temperature Range		-65 to 200°C		
R _{thJA}	Thermal Resistance Junction to Ambient		350°C		

Semelab Plc reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by Semelab is believed to be both accurate and reliable at the time of going to press. However Semelab assumes no responsibility for any errors or omissions discovered in its use. Semelab encourages customers to verify that datasheets are current before placing orders.





ELECTRICAL CHARACTERISTICS ($T_{case} = 25^{\circ}C$ unless otherwise stated)

	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
OFF CH	IARACTERISTICS				•	
V _{(BR)CEO}	Collector-Emitter Breakdown Voltage ¹	I _C =10mA I _B =0	150			V
V _{(BR)CBO}	Collector-Base Breakdown Voltage	Ι _C =10μΑ Ι _E =0	150			V
V _{(BR)EBO}	Emitter-Base Breakdown Voltage	Ι _Ε =10μΑ Ι _C =0	6			V
I _{CBO}	Collector Cutoff Current	V _{CB} =75V I _E =0			0.05	μA
		T _{amb} =150°C			50	
I _{EBO}	Emitter Cutoff Current	V _{BE(off)} =4V V _{CE} =0			25	nA
ON CH	ARACTERISTICS				•	
h _{FE}	DC Current Gain	I _C =0.1mA V _{CE} =10V	35			
		I _C =1mA V _{CE} =10V	50			
		I _C =10 mA V _{CE} =10V	75			
		I _C =150 mA V _{CE} =10V	100		300	
		I _C =300 mA V _{CE} =10V	20			
V _{CE(SAT)}	Collector-Emitter Saturation Voltage ¹	I _C =10mA I _B =1mA			0.2	V
		I _C =50mA I _B =5mA			0.25	
		I _C =150 mA I _B =15mA			0.4	
V _{BE(SAT)}	Base-Emitter Saturation Voltage ¹	I _C =10mA I _B =1mA			0.8	V
		I _C =50mA I _B =5mA			0.9	
		I _C =150 mA I _B =15mA			1.2	
SMALL S	SIGNAL CHARACTERISTICS					
f _T	Current Gain-Bandwidth Product (100MHz)	V _{CE} =20V I _C =20mA	150			MHz
C _{obo}	Output Capacitance (1MHz)	V _{CB} =10V I _E =0			8	nE
C _{ibo}	Input Capacitance (1MHz)	V _{EB} =0.5V I _C =0			80	- pF
h _{ie}	Input Impedance (1kHz)	V _{CE} =10V I _C =10mA	0.25		1.25	`
h _{fe}	Small-Signal Current Gain (1kHz)	V _{CE} =10V I _C =10mA			375	
h _{oe}	Output Admittance (1kHz)	V _{CE} =10V I _C =10mA			200	`
	ING CHARACTERISTICS					
t _d	Delay Time	I _C =150mA I _B ¹ =15mA		20		
t _r	Rise Time	V _{CC} =100V V _{EB(off)} =-2V		35		ns
t _s	Storage Time	I _C =150mA I _B ¹ =15mA		800		- 115
t _f	Fall Time	I _{B1} =I _{B2} =15mA		80		

1) Pulse Test: Pulse Width < 300 μ s, Duty Cycle <2%

2) f_t is defined as frequency at which $|h_{fe}|.f_{test}$

Semelab Plc reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by Semelab is believed to be both accurate and reliable at the time of going to press. However Semelab assumes no responsibility for any errors or omissions discovered in its use. Semelab encourages customers to verify that datasheets are current before placing orders.